

Notice of References Cited	Application/Control No. 10/534,012	Applicant(s)/Patent Under Reexamination NAUKKARINEN ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0140745	10-2002	Ellenby et al.	345/848
	B	US-2003/0135327	07-2003	Levine et al.	701/220
	C	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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